

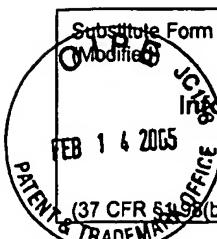
Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13909-142001	Application No. 10/617,141
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Martin Kaiser et al.		
		Filing Date July 11, 2003	Group Art Unit 2171	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
clcl	AA	US-4849905	07-1989	Loeb et al.			
clcl	AB	US-5355473	10-1994	Au			
clcl	AC	US-5557786	09-1996	Johnson, Jr.			
clcl	AD	US-5737732	04-1998	Gibson et al.			

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
clcl	AE	0 657 830 A1	06-1995	EPO			

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
clcl	AF	Date, C.J., "Introduction to Database Systems, Vol. 1," 1990, Addison Wesley, Reading, MA, USA, paragraph '03.6!, figs. 3.17 and 3.18
clcl	AG	Haerder, Theo and Erhard Rahm, "Datenbanksysteme," 1999, Springer, Heidelberg, pp. 207-210, 227-233, figs. 7.15, 8.1 and 8.2.B, English translation provided, 10 pgs.
	AH	
	AI	

Examiner Signature 	Date Considered 01/09/2006
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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cld	AA	US-2002/0032676 A1	03/14/2002	Wheat et al.			

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No
cld	AB	WO 02/061612 A	08/08/2002	WIPO			
cld	AC	WO 02/061613 A	08/08/2002	WIPO			

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